

POWER MOSFET THRU-HOLE (TO-254AA)

60V, N-CHANNEL HEXFET MOSFET TECHNOLOGY

Product Summary

| Part Number | R _{DS(on)} | Ι _D | |
|-------------|---------------------|----------------|--|
| IRFM064 | 0.017Ω | 35A* | |

TO-254AA

Description

HEXFET MOSFET technology is the key to IR HiRel advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high trans conductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heat sink. This improves thermal efficiency and reduces drain capacitance.

Features

- Simple Drive Requirements
- Hermetically Sealed
- Electrically Isolated
- Dynamic dv/dt Rating
- Light Weight

Absolute Maximum Ratings

| Symbol | Parameter | Value | Units |
|---|---------------------------------|---|-------|
| I_{D1} @ V_{GS} = 10V, T_{C} = 25°C | Continuous Drain Current | 35* | |
| I _{D2} @ V _{GS} = 10V, T _C = 100°C | Continuous Drain Current | 35* | Α |
| I _{DM} @T _C = 25°C | Pulsed Drain Current ① | 380 | |
| P _D @T _C = 25°C | Maximum Power Dissipation | 250 | W |
| | Linear Derating Factor | 2.0 | W/°C |
| V_{GS} | Gate-to-Source Voltage | ± 20 | V |
| E _{AS} | Single Pulse Avalanche Energy ② | 620 | mJ |
| I _{AR} | Avalanche Current ① | 35 | Α |
| E _{AR} | Repetitive Avalanche Energy ① | 25 | mJ |
| dv/dt | Peak Diode Recovery dv/dt ③ | 4.5 | V/ns |
| T _J | Operating Junction and | -55 to + 150 | |
| T _{STG} | Storage Temperature Range | | °C |
| | Lead Temperature | 300 (0.063 in. /1.6 mm from case for 10s) | |
| | Weight | 9.3 (Typical) | g |

^{*} Current is limited by package For Footnotes refer to the page 2.



Electrical Characteristics @ T_j = 25°C (Unless Otherwise Specified)

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|--------------------------------|---|------|-------|------------|-------|---|
| BV _{DSS} | Drain-to-Source Breakdown Voltage | 60 | | | V | $V_{GS} = 0V, I_{D} = 1.0mA$ |
| $\Delta BV_{DSS}/\Delta T_{J}$ | Breakdown Voltage Temp. Coefficient | | 0.048 | | V/°C | Reference to 25°C, I _D = 1.0mA |
| R _{DS(on)} | Static Drain-to-Source On-State Resistance | | | 0.017 | Ω | V _{GS} = 10V, I _{D2} = 35A ④ |
| $V_{GS(th)}$ | Gate Threshold Voltage | 2.0 | | 4.0 | V | $V_{DS} = V_{GS}$, $I_D = 250\mu A$ |
| Gfs | Forward Transconductance | 21 | | | S | V _{DS} = 15V, I _{D2} = 35A ④ |
| I _{DSS} | Zero Gate Voltage Drain Current | | | 25 | μA | $V_{DS} = 48V, V_{GS} = 0V$ |
| I _{GSS} | Gate-to-Source Leakage Forward | | | 250 100 | • | $V_{DS} = 48V, V_{GS} = 0V, T_{J} = 125^{\circ}C$ $V_{GS} = 20V$ |
| iGSS | Gate-to-Source Leakage Reverse | | | -100 | nA | $V_{GS} = -20V$ |
| Q_{G} | Total Gate Charge | | | 240 | | I _{D1} = 35A |
| Q _{GS} | Gate-to-Source Charge | | | 53 | nC | V _{DS} = 30V |
| Q_{GD} | Gate-to-Drain ('Miller') Charge | | | 78 | | V _{GS} = 10V |
| t _{d(on)} | Turn-On Delay Time | | | 27 | | V _{DD} = 30V |
| tr | Rise Time | | | 120 | no | I _{D1} = 35A |
| $t_{d(off)}$ | Turn-Off Delay Time | | | 76 | ns | $R_G = 2.35\Omega$ |
| t _f | Fall Time | | | 93 | | V _{GS} = 10V |
| Ls +L _D | Total Inductance | | 6.8 | | nH | Measured from Drain lead (6mm / 0.25 in from package) to Source lead (6mm/0.25 in from package) with Source wire internally bonded from Source pin to Drain pad |
| C _{iss} | Input Capacitance | | 7400 | | | V _{GS} = 0V |
| C _{oss} | Output Capacitance | | 3200 | | pF | V _{DS} = 25V |
| C _{rss} | Reverse Transfer Capacitance | | 540 | | | f = 1.0MHz |

Source-Drain Diode Ratings and Characteristics

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|-----------------|--|--|------|------|-------|--|
| Is | Continuous Source Current (Body Diode) | | | 35* | ۸ | |
| I _{SM} | Pulsed Source Current (Body Diode) ① | | | 380 | Α | |
| V_{SD} | Diode Forward Voltage | | | 3.0 | V | $T_J = 25^{\circ}C, I_S = 35A, V_{GS} = 0V$ |
| t _{rr} | Reverse Recovery Time | | | 220 | ns | $T_J = 25^{\circ}C, I_F = 35A, V_{DD} \le 50V$ |
| Q _{rr} | Reverse Recovery Charge | | | 1.1 | μC | di/dt = 100A/µs ④ |
| t _{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D) | | | | |

^{*} Current is limited by package

Thermal Resistance

| Symbol | Parameter | Min. | Тур. | Max. | Units |
|-----------------|--|------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case | | | 0.5 | |
| $R_{\theta CS}$ | Case -to-Sink | | 0.21 | | °C/W |
| $R_{\theta JA}$ | Junction-to-Ambient (Typical socket mount) | | | 48 | |

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- $^{\circ}$ V_{DD} = 25V, starting T_J = 25°C, L = 1.0mH, Peak I_L = 35A, V_{GS} = 10V
- $\label{eq:local_spin_spin} \text{$\mathbb{J}_{SD} \leq 35A$, $di/dt \leq 300A/\mu s$, $V_{DD} \leq 60V$, $T_J \leq 150^{\circ}C$ }$
- 4 Pulse width $\leq 300 \ \mu s$; Duty Cycle $\leq 2\%$.



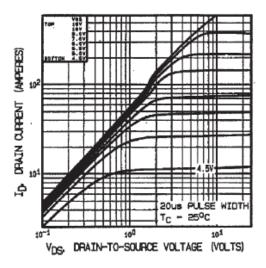


Fig 1. Typical Output Characteristics

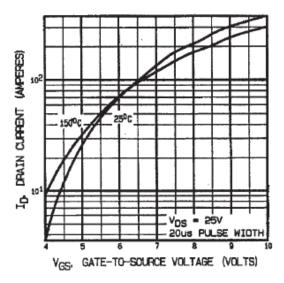


Fig 3. Typical Transfer Characteristics

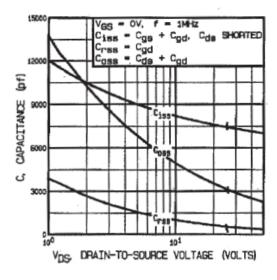


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

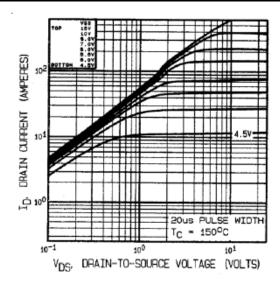


Fig 2. Typical Output Characteristics

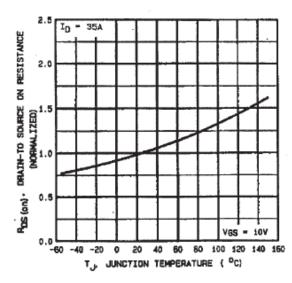


Fig 4. Normalized On-Resistance Vs. Temperature

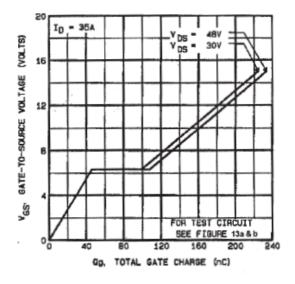


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

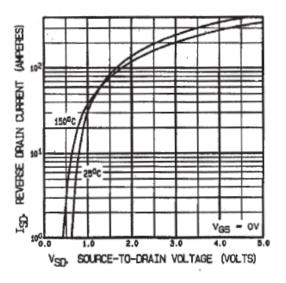


Fig 7. Typical Source-Drain Diode Forward Voltage

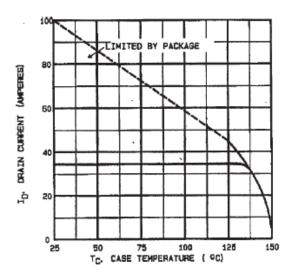


Fig 9. Maximum Drain Current Vs. Case Temperature

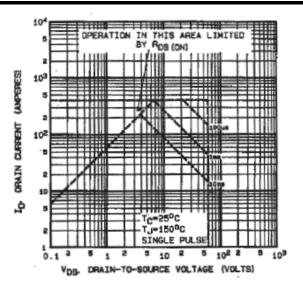


Fig 8. Maximum Safe Operating Area

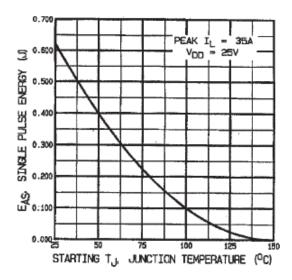


Fig 10. Maximum Avalanche Energy Vs. Drain Current

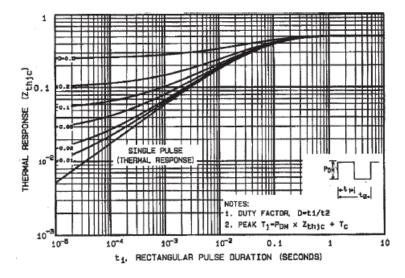


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



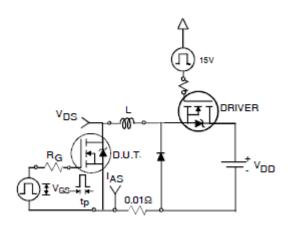


Fig 12a. Unclamped Inductive Test Circuit

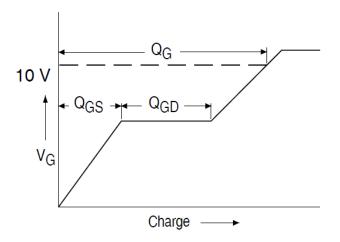


Fig 13a. Basic Gate Charge Waveform

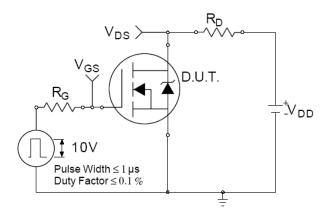


Fig 14a. Switching Time Test Circuit

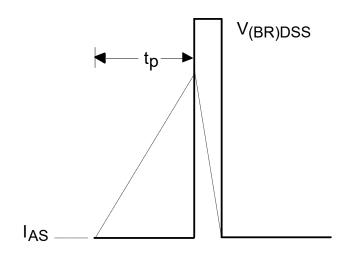


Fig 12b. Unclamped Inductive Waveforms

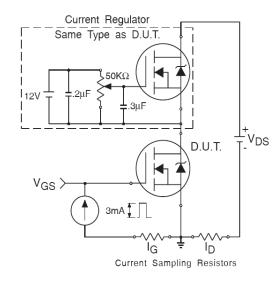


Fig 13b. Gate Charge Test Circuit

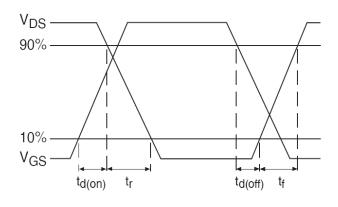
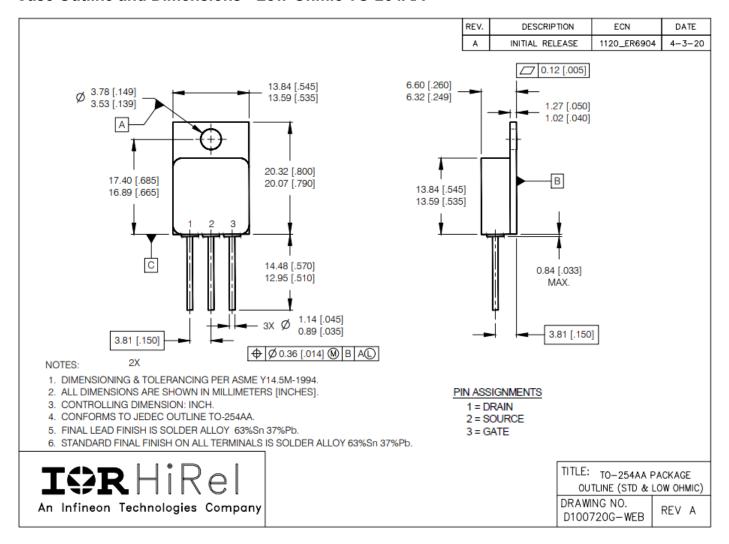


Fig 14b. Switching Time Waveforms



Note: For the most updated package outline, please see the website: TO-254AA

Case Outline and Dimensions - Low-Ohmic TO-254AA



BERYLLIA WARNING PER MIL-PRF-19500

Package containing beryllia shall not be ground, sandblasted, machined, or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.



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